

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	10905	stray\$4 near10 light\$6	US-PGPUB; USPAT	OR	ON	2005/08/01 16:33
L2	1303	1 same(correction\$3 or adjust\$4 or enhanc\$6)	US-PGPUB; USPAT	OR	ON	2005/08/01 16:23
L3	152	2 same(color\$3)	US-PGPUB; USPAT	OR	ON	2005/08/01 16:24
L4	157	2 same(color\$3 or colour\$2)	US-PGPUB; USPAT	OR	ON	2005/08/01 16:34
L5	4	4 same(gray\$4 or grey\$4)	US-PGPUB; USPAT	OR	ON	2005/08/01 17:53
L6	844	(stray\$4 near10 light\$6)and(colour\$3 or color\$3)and(gray\$3 or grey\$4)	US-PGPUB; USPAT	OR	ON	2005/08/01 16:25
L7	781	6 and(correct\$6 or adjust\$6 or enhanc\$6)	US-PGPUB; USPAT	OR	ON	2005/08/01 16:27
L8	44	7 and(solid\$6 near10 array\$3)	US-PGPUB; USPAT	OR	ON	2005/08/01 16:28
L9	44	8 and(calculat\$6 or multipl\$3 or comput\$6 or sabtract\$4)	US-PGPUB; USPAT	OR	ON	2005/08/01 16:35
L10	10	9 and(bright\$6 near10(compar\$6 or correlat\$6 or match\$4))	US-PGPUB; USPAT	OR	ON	2005/08/01 16:35
L11	47782	((stray\$4 or reflect\$6) near10 light\$6)same(correction\$3 or adjust\$6 or enhanc\$6)	US-PGPUB; USPAT	OR	ON	2005/08/01 16:34
L12	6981	11 same(color\$3 or colour\$2)	US-PGPUB; USPAT	OR	ON	2005/08/01 16:34
L13	273	12 same(gray\$4 or grey\$4)	US-PGPUB; USPAT	OR	ON	2005/08/01 16:34
L14	204	13 and(calculat\$6 or multipl\$3 or comput\$6 or sabtract\$4)	US-PGPUB; USPAT	OR	ON	2005/08/01 16:35
L15	27	14 and(bright\$6 near10(compar\$6 or correlat\$6 or match\$4))	US-PGPUB; USPAT	OR	ON	2005/08/01 16:35
L16	1	"6396217".PN.	USPAT; USOCR	OR	ON	2005/08/01 17:53
L17	1	"6297859".PN.	USPAT; USOCR	OR	ON	2005/08/01 17:53
L18	1	"5760843".PN.	USPAT; USOCR	OR	ON	2005/08/01 17:53
L19	1	"5760843".PN.	USPAT; USOCR	OR	ON	2005/08/01 17:53
L20	1	"5287173".PN.	USPAT; USOCR	OR	ON	2005/08/01 17:53
L21	1	"6489601".PN.	USPAT; USOCR	OR	ON	2005/08/01 17:54

L22	1	"6301019".PN.	USPAT; USOCR	OR	ON	2005/08/01 17:54
L23	1	"6229627".PN.	USPAT; USOCR	OR	ON	2005/08/01 17:54


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Key: IEEE JNL = IEEE Journal or Magazine, IEEE JNL = IEEE Journal or Magazine, IEEE CNF = IEEE Conference, IEEE CNF = IEEE Conference, IEEE STD = IEEE Standard

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